# ES51C1A10V-12.800M TR



Packaging Options Tape & Reel

Nominal Frequency

#### ES51C1 A 10 V -12.800M TR



Operating Temperature Range 0°C to +50°C

12.800MHz **Control Voltage** 1.5Vdc ±1.0Vdc

Frequency Stability -±1.0ppm Maximum

#### **ELECTRICAL SPECIFICATIONS** Nominal Frequency 12.800MHz Frequency Stability vs. Frequency ±1.0ppm Maximum (Measured at 25°C ±2°C, Vdd=5.0Vdc, Vc=1.5Vdc) Tolerance Frequency Stability ±1.0ppm Maximum Frequency Stability vs. Input Voltage ±0.2ppm Maximum (Vdd ±5%) Frequency Stability vs. Aging ±1ppm/Year Maximum (at 25°C) Frequency Stability vs. Load ±0.2ppm Maximum (±1kOhm//±1pF) 0°C to +50°C **Operating Temperature Range** Supply Voltage 5.0 / dc + 5%

| Supply Voltage            | 5.0Vdc ±5%   |
|---------------------------|--|
| Input Current             | 1.5mA Maximum  |
| Output Voltage            | 0.8Vp-p Clipped Sinewave Minimum   |
| Load Drive Capability     | 10kOhms//10pF  |
| Output Logic Type         | Clipped Sinewave   |
| Control Voltage           | 1.5Vdc ±1.0Vdc   |
| Frequency Deviation       | ±8ppm Minimum  |
| Linearity                 | 10% Maximum  |
| Transfer Function         | Positive Transfer Characteristic   |
| Modulation Bandwidth      | 3kHz Minimum (Measured at -3dB with a Control Voltage of 1.5Vdc)   |
| Input Impedance           | 100kOhms Minimum   |
| Phase Noise               | -80dBc/Hz at 10Hz offset, -115dBc/Hz at 100Hz offset, -135dBc/Hz at 1kHz offset, -145dBc/Hz at 10kHz offset, -145dBc/Hz at 10kHz offset (Typical Values, at 12.800MHz) |
| Start Up Time             | 5mSec Maximum  |
| Storage Temperature Range | -55°C to +125°C  |

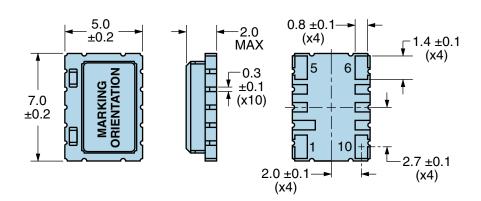
### **ENVIRONMENTAL & MECHANICAL SPECIFICATIONS**

| Fine Leak Test               | MIL-STD-883, Method 1014 Condition A |
|------------------------------|--------------------------------------|
| Gross Leak Test              | MIL-STD-883, Method 1014 Condition C |
| Mechanical Shock             | MIL-STD-202, Method 213 Condition C  |
| Resistance to Soldering Heat | MIL-STD-202, Method 210              |
| Resistance to Solvents       | MIL-STD-202, Method 215              |
| Solderability                | MIL-STD-883, Method 2003             |
| Temperature Cycling          | MIL-STD-883, Method 1010             |
| Vibration                    | MIL-STD-883, Method 2007 Condition A |

## **ECLIPTEK** CORPORATION

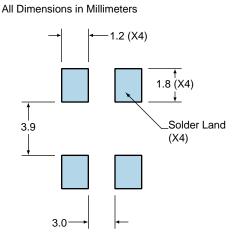
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### **MECHANICAL DIMENSIONS (all dimensions in millimeters)**



| PIN  | CONNECTION  |
|------|---|
| 1    | Voltage Control   |
| 2    | Do Not Connect  |
| 3    | Do Not Connect  |
| 4    | Do Not Connect  |
| 5    | Case/Ground   |
| 6    | Output  |
| 7    | Do Not Connect  |
| 8    | Do Not Connect  |
| 9    | Do Not Connect  |
| 10   | Supply Voltage  |
| LINE | MARKING   |
| 1    | E12.800<br>E=Ecliptek   |
| 2    | XXYZZ<br>XX=Ecliptek Manufacturing<br>Code<br>Y=Last Digit of the Year<br>ZZ=Week of the Year |

### Suggested Solder Pad Layout

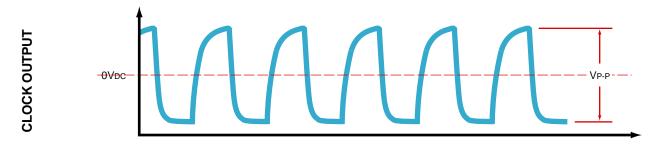


All Tolerances are ±0.1

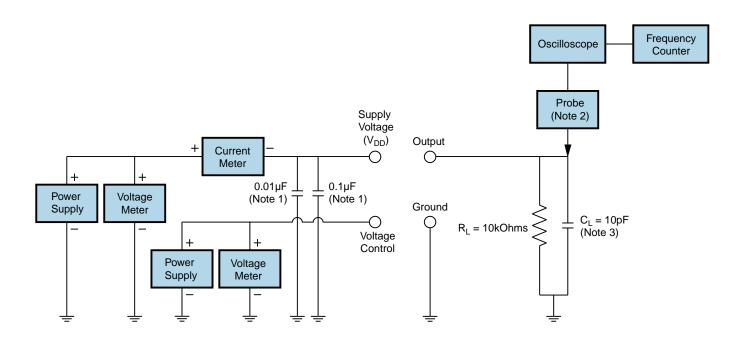
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### OUTPUT WAVEFORM



### **Test Circuit for Voltage Control Option**



Note 1: An external 0.1  $\mu F$  low frequency tantalum bypass capacitor in parallel with a 0.01  $\mu F$  high frequency ceramic bypass capacitor close to the package ground and V\_{DD} pin is required.

Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

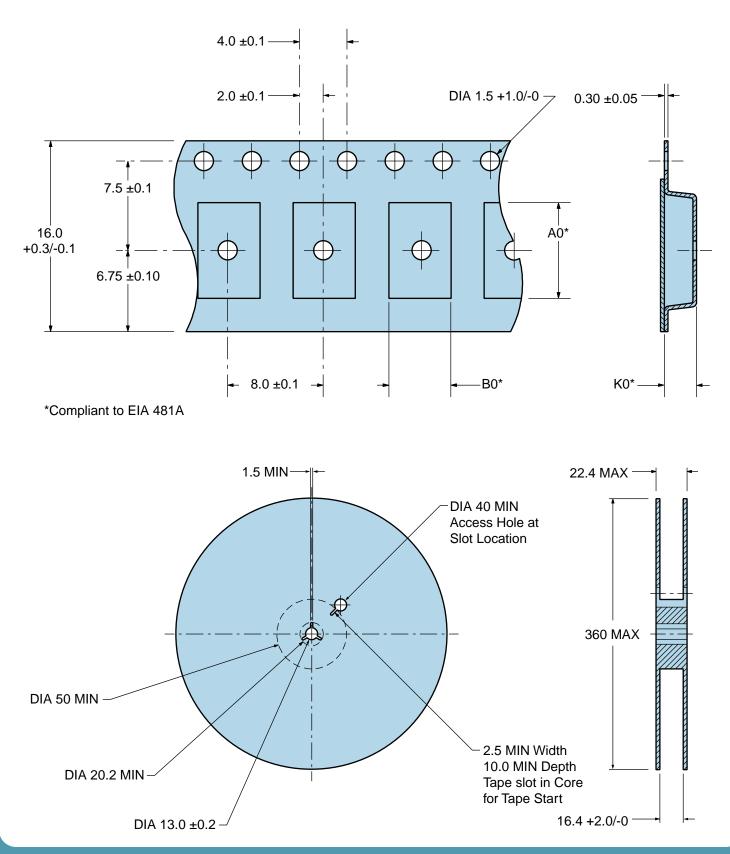
Note 3: Capacitance value  $C_L$  includes sum of all probe and fixture capacitance.

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# **Tape & Reel Dimensions**

Quantity Per Reel: 1,000 units

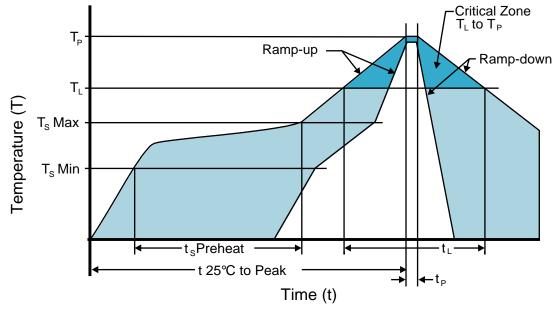


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## **Recommended Solder Reflow Methods**

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### Low Temperature Infrared/Convection 220°C

| T <sub>s</sub> MAX to T <sub>L</sub> (Ramp-up Rate) | 5°C/second Maximum                                    |
|---|---|
| Preheat   |   |
| - Temperature Minimum (T <sub>s</sub> MIN)          | N/A   |
| - Temperature Typical (T <sub>s</sub> TYP)          | 150°C   |
| - Temperature Maximum (T <sub>s</sub> MAX)          | N/A   |
| - Time (t <sub>s</sub> MIN)                         | 60 - 120 Seconds                                      |
| Ramp-up Rate (T⊾ to T <sub>P</sub> )                | 5°C/second Maximum                                    |
| Time Maintained Above:                              |   |
| - Temperature (T∟)                                  | 150°C   |
| - Time (t∟)   | 200 Seconds Maximum                                   |
| Peak Temperature (T <sub>P</sub> )                  | 220°C Maximum   |
| Target Peak Temperature (T <sub>P</sub> Target)     | 220°C Maximum 1 Time / 215°C Maximum 1 Time           |
| Time within 5°C of actual peak (t <sub>p</sub> )    | 15 seconds Maximum 1 Time / 80 seconds Maximum 1 Time |
| Ramp-down Rate                                      | 5°C/second Maximum                                    |
| Time 25°C to Peak Temperature (t)                   | N/A   |
| Moisture Sensitivity Level                          | Level 1   |

#### Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum.

#### **High Temperature Manual Soldering**

260°C Maximum for 5 seconds Maximum, 2 times Maximum.